

Search Notes



Application No.

10/668,162

Examiner

Chen-Wen Jiang

Applicant(s)

LEE ET AL.

Art Unit

3744

SEARCHED

Class	Subclass	Date	Examiner
62	406 412		
	271		
	275		
	94		
	171 238.3		
	238.6 229		
	228		
	158 160	7/28/04	CJ

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EPST Search Note Attached Inventor Searched	7/28/04	CJ